

Client

EMC Technologies

CALIBRATION CERTIFICATE

Object(s)

ET3DV6 - SN:1380

Calibration procedure(s)

QA CAL-01.v2

Calibration procedure for dosimetric E-field probes

Calibration date:

July 14, 2004

Condition of the calibrated item

In Tolerance (according to the specific calibration document)

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature 22 ± 2 degrees Celsius and humidity < 75%.

Calibration Equipment used (M&TE critical for calibration)

Model Type	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter EPM E4419B	GB41293874	5-May-04 (METAS, No 251-00388)	May-05
Power sensor E4412A	MY41495277	5-May-04 (METAS, No 251-00388)	May-05
Reference 20 dB Attenuator	SN: 5086 (20b)	3-May-04 (METAS, No 251-00389)	May-05
Fluke Process Calibrator Type 702	SN: 6295803	8-Sep-03 (Sintrel SCS No. E030020)	Sep-04
Power sensor HP 8481A	MY41092180	18-Sep-02 (SPEAG, in house check Oct03)	In house check: Oct 05
RF generator HP 8684C	US3642U01700	4-Aug-99 (SPEAG, in house check Aug02)	In house check: Aug05
Network Analyzer HP 8753E	US37390585	18-Oct-01 (SPEAG, in house check Oct03)	In house check: Oct 05

Calibrated by:

Name

Nico Vetterli

Function

Technician

Signature



Approved by:

Katja Pokovic

Laboratory Director



Date issued: July 14, 2004

This calibration certificate is issued as an intermediate solution until the accreditation process (based on ISO/IEC 17025 International Standard) for Calibration Laboratory of Schmid & Partner Engineering AG is completed.

Probe ET3DV6

SN:1380

Manufactured:	August 16, 1999
Last calibrated:	July 18, 2003
Recalibrated:	July 14, 2004

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

DASY - Parameters of Probe: ET3DV6 SN:1380

Sensitivity in Free Space

NormX	1.73 $\mu\text{V}/(\text{V}/\text{m})^2$
NormY	1.65 $\mu\text{V}/(\text{V}/\text{m})^2$
NormZ	1.80 $\mu\text{V}/(\text{V}/\text{m})^2$

Diode Compression^A

DCP X	90	mV
DCP Y	90	mV
DCP Z	90	mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 7.

Boundary Effect

TSL 2450 MHz Typical SAR gradient: 12 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR _{be} [%]	Without Correction Algorithm	17.2	10.4
SAR _{be} [%]	With Correction Algorithm	0.3	0.9

Sensor Offset

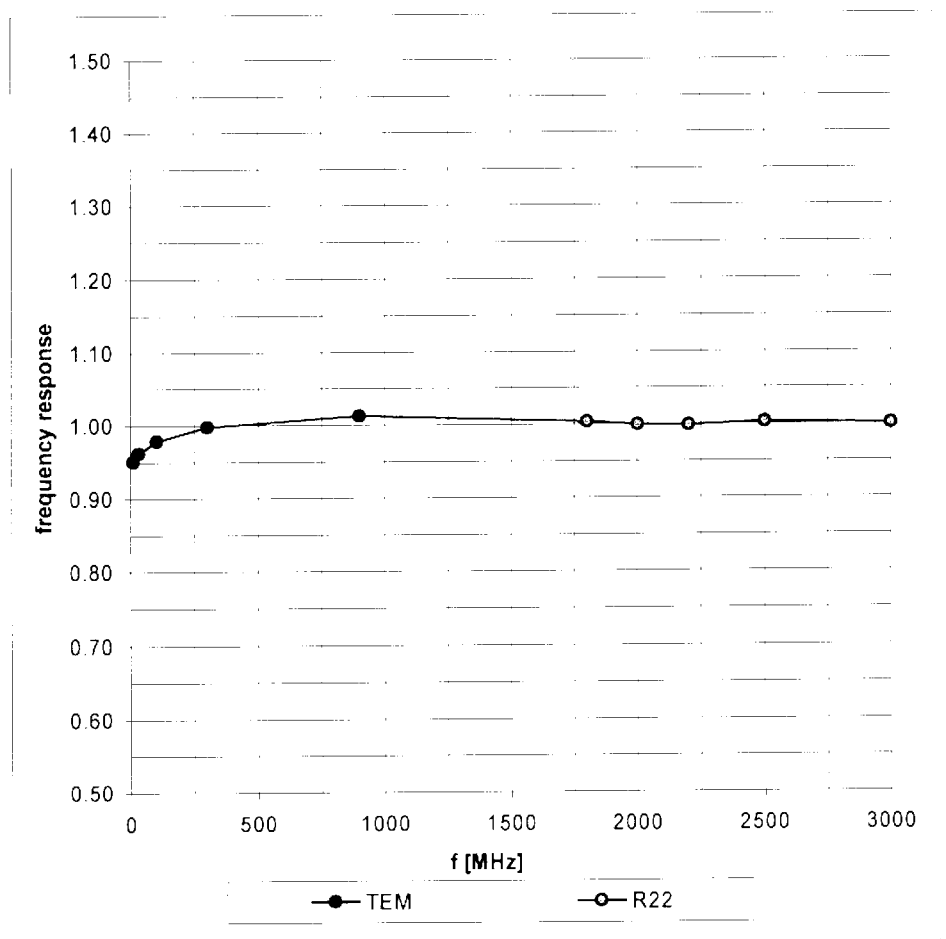
Probe Tip to Sensor Center	2.7 mm
Optical Surface Detection	in tolerance

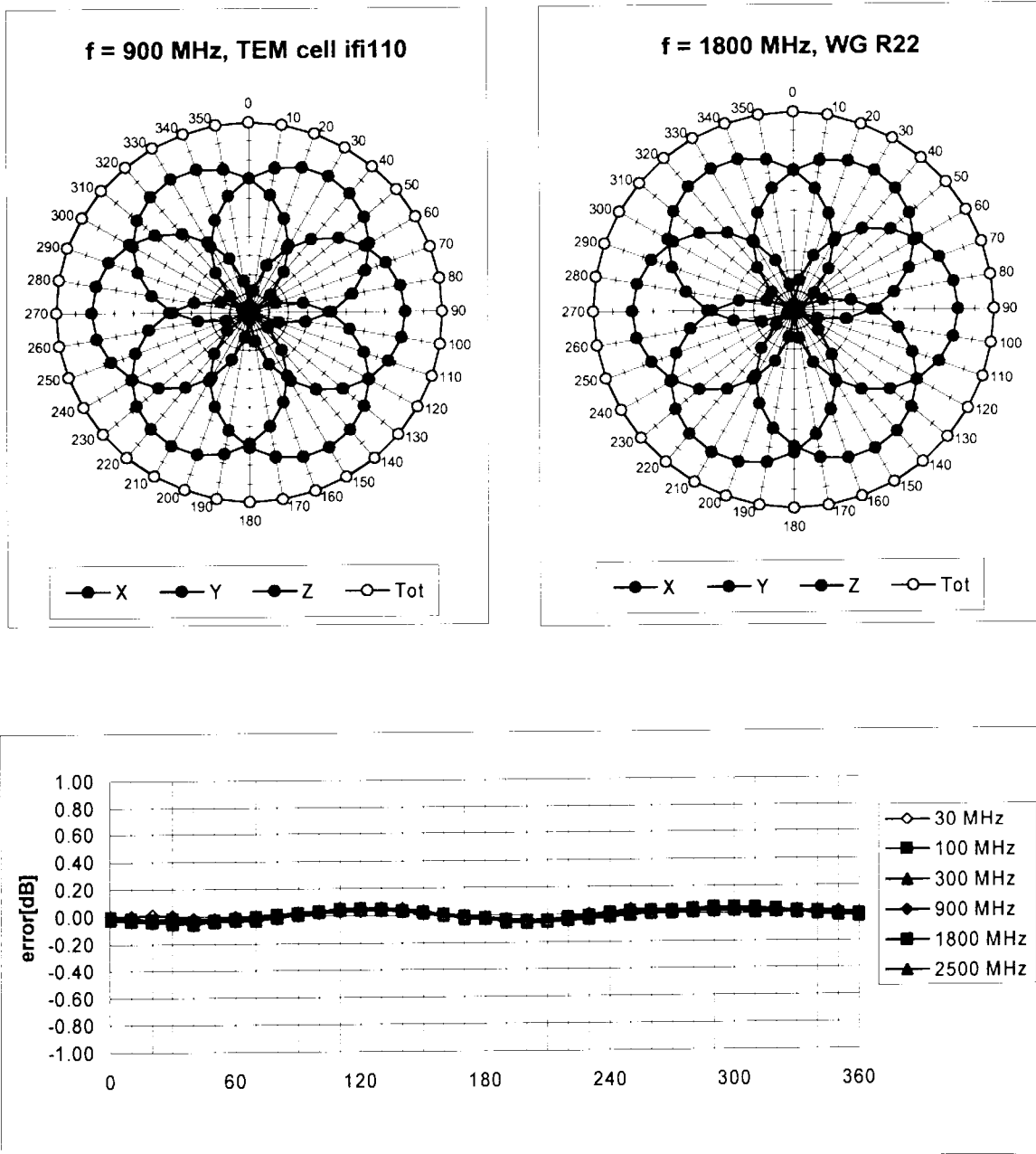
The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A numerical linearization parameter: uncertainty not required

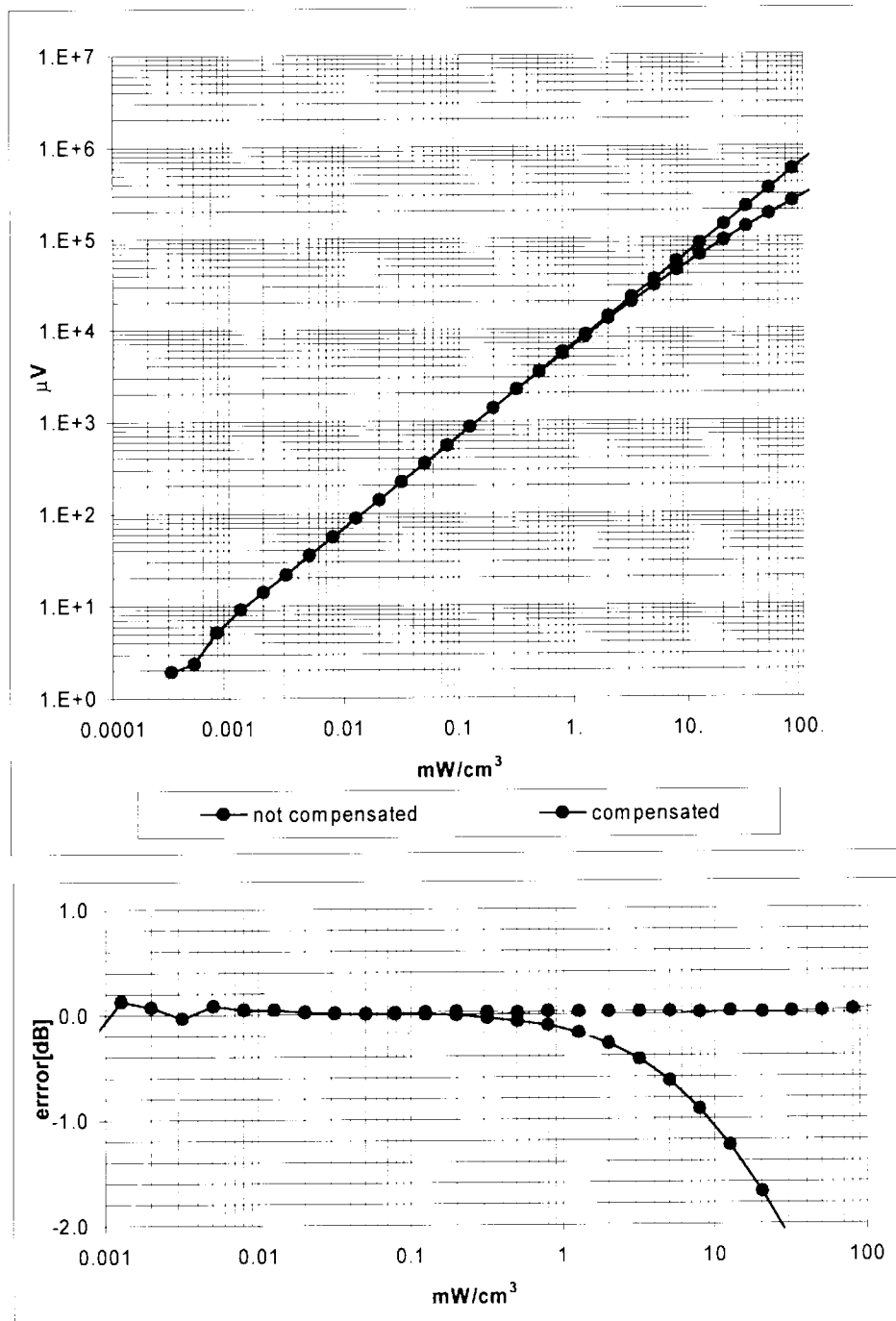
Frequency Response of E-Field

(TEM-Cell:ifi110, Waveguide R22)



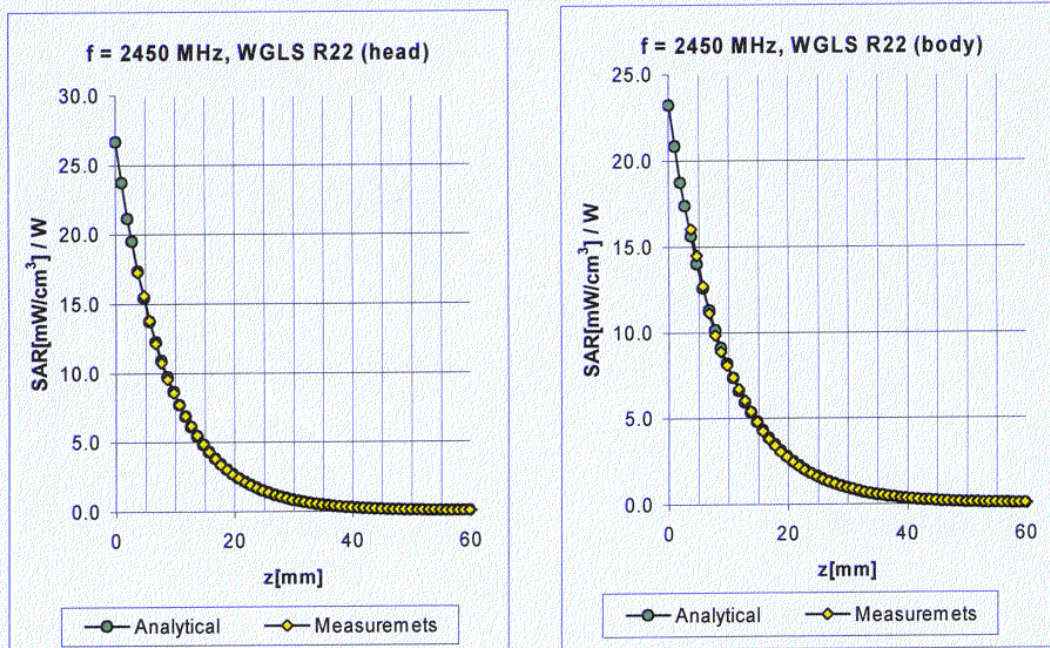
Receiving Pattern (ϕ), $\theta = 0^\circ$ Axial Isotropy Error $< \pm 0.2$ dB

Dynamic Range $f(\text{SAR}_{\text{head}})$ (Waveguide R22)



Probe Linearity Error $< \pm 0.2$ dB

Conversion Factor Assessment

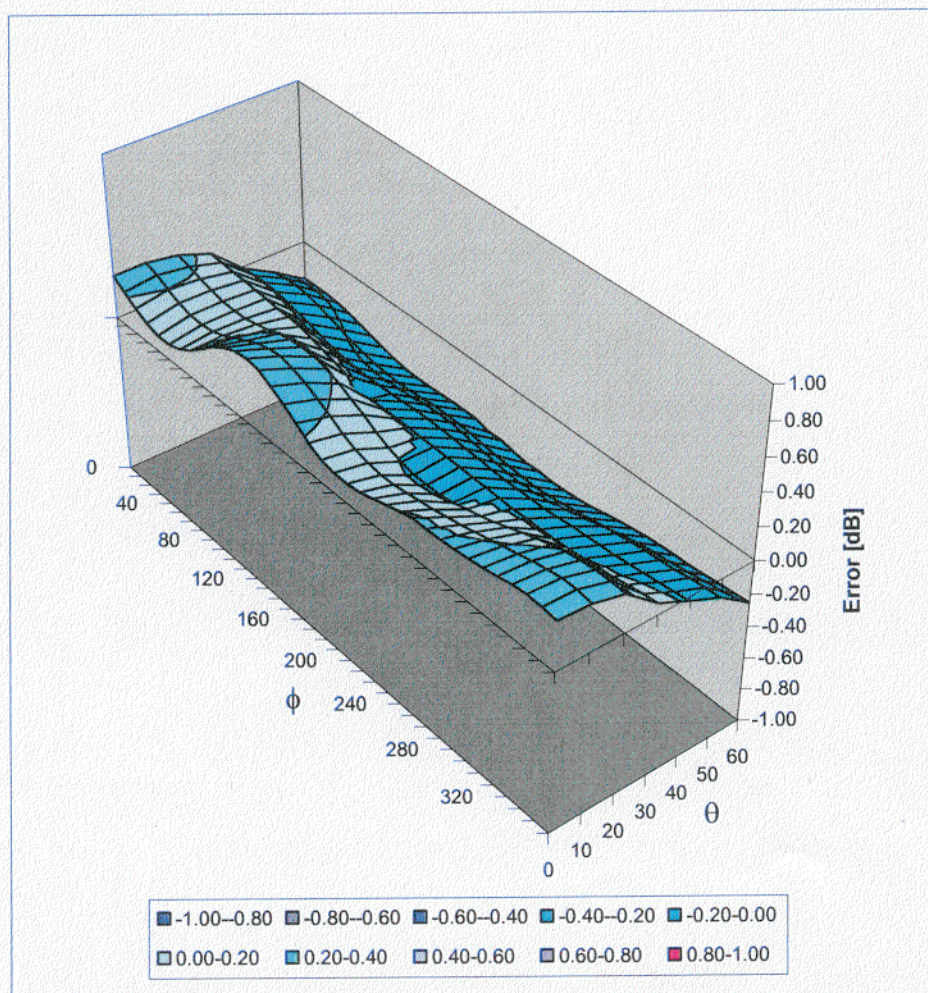


f [MHz]	Validity [MHz] ^B	Tissue	Permittivity	Conductivity	Alpha	Depth	ConvF	Uncertainty
2450	2400-2500	Head	39.2 ± 5%	1.80 ± 5%	1.16	1.81	4.47	± 9.7% (k=2)
2450	2400-2500	Body	52.7 ± 5%	1.95 ± 5%	1.41	1.52	4.16	± 9.7% (k=2)

^B The total standard uncertainty is calculated as root-sum-square of standard uncertainty of the Conversion Factor at calibration frequency and the standard uncertainty for the indicated frequency band.

Deviation from Isotropy in HSL

Error (θ, ϕ), $f = 900$ MHz



Spherical Isotropy Error $< \pm 0.4$ dB